

FROM RESEARCH TO INDUSTRY



CEA LIST activity on *Cable Monitoring and Diagnosis*

Contact :

Mr Josy COHEN – Responsable de projet &
ingénieur chercheur

Josy.cohen@cea.fr

+33 1 69 08 78 07

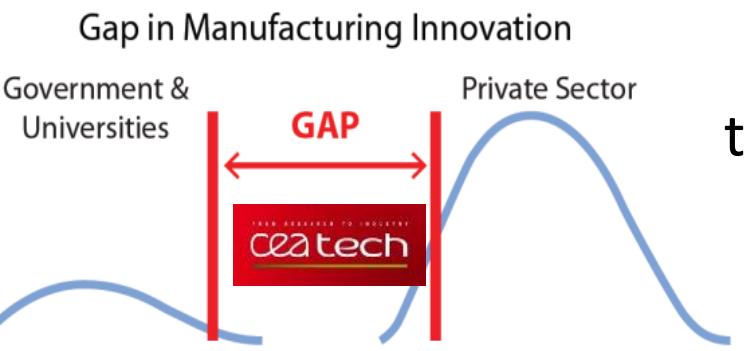
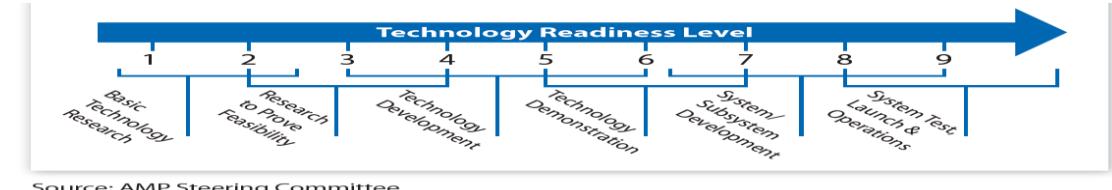
CEA experience in cable diagnosis

■ Our Laboratory :

LFIC : Laboratoire Fiabilité et Capteurs Intégrés

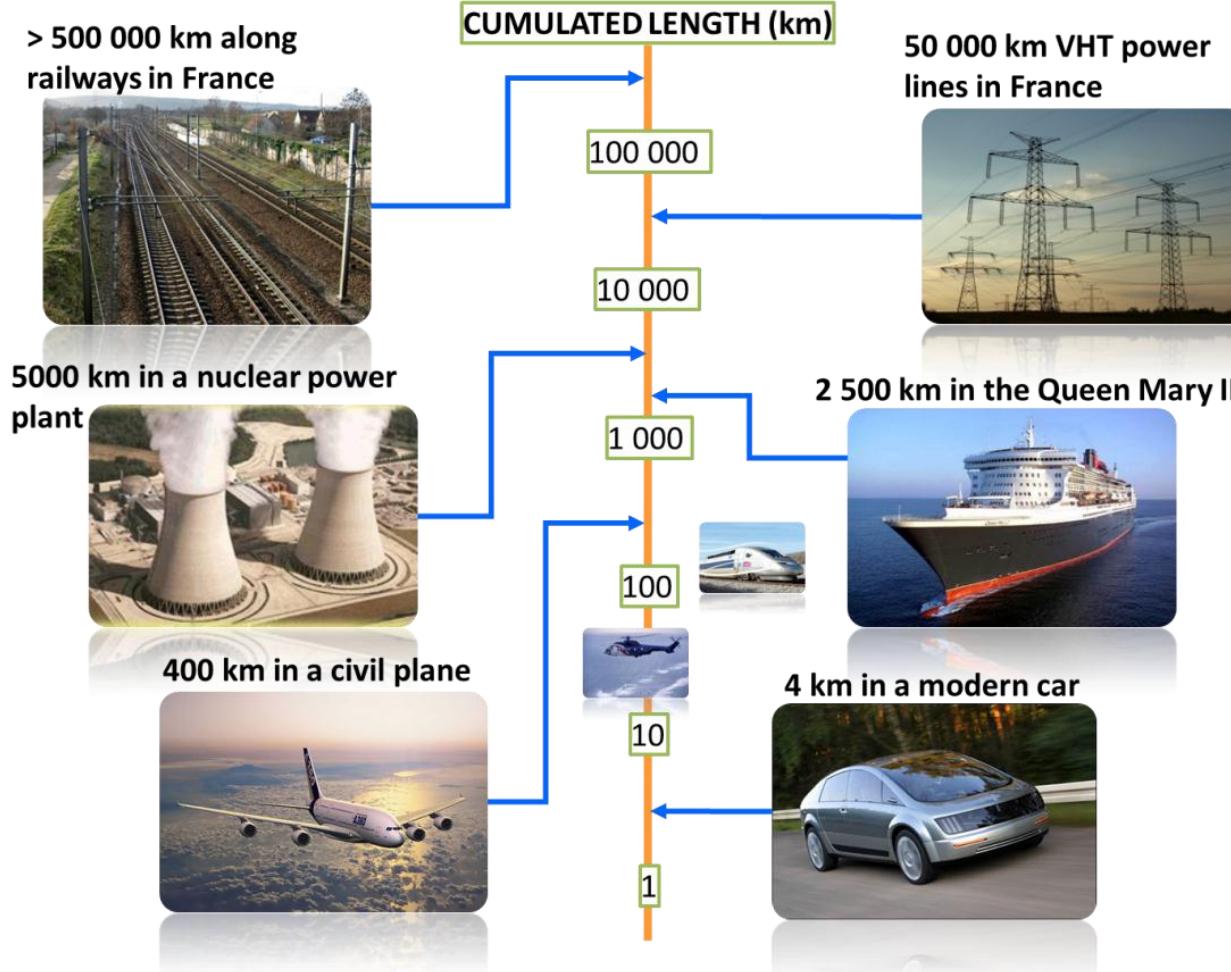
More than 10 years experience and knowledge in
network cable diagnosis

■ CEA policy :



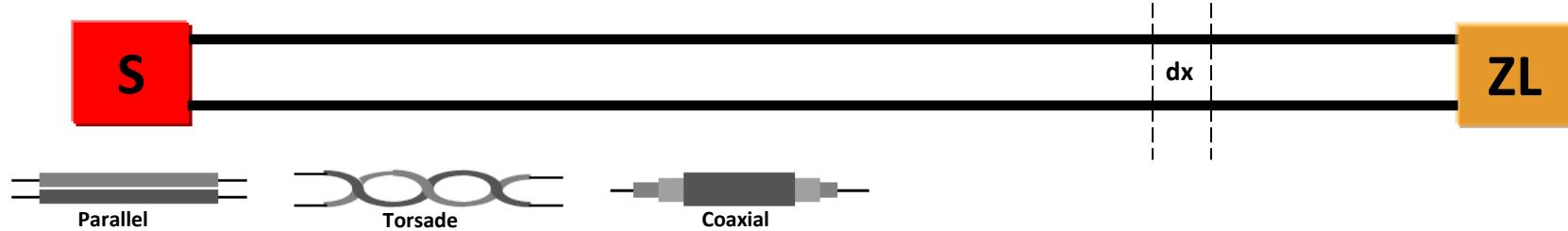
To create breakthrough
to take advantage and to create new jobs
by industrial transfer
for French companies

Ubiquitous cable



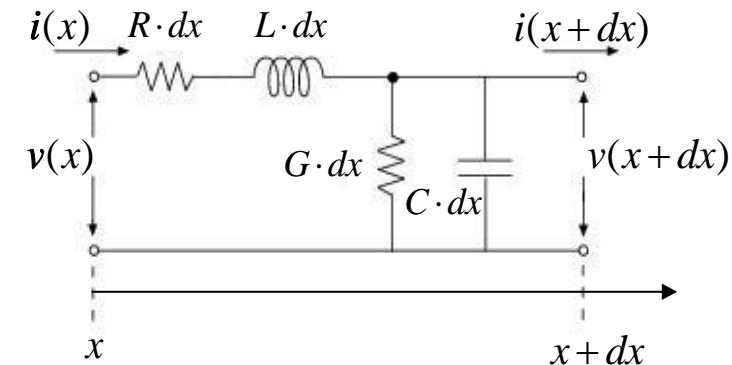
Reflectometry : Principle

- The reflectometry principle is related to the signal propagation mechanism into a transmission line (TL)



Modeling and characterization of a TL

- R, L, C, G Model
 - based on Telegrapher's equations
- to figure out how a signal is propagated into a TL
- we have to look signal distortion phenomenon
- Attenuation and dispersion



Telegrapher's equations

$$\frac{\partial^2 v(x,t)}{\partial x^2} = LC \cdot \frac{\partial^2 v(x,t)}{\partial t^2} + (LG + RC) \cdot \frac{\partial v(x,t)}{\partial t} + RG \cdot v(x,t)$$

$$Z_c = \sqrt{\frac{R + jL\omega}{G + jC\omega}} \quad V_g = \frac{1}{\sqrt{LC}}$$

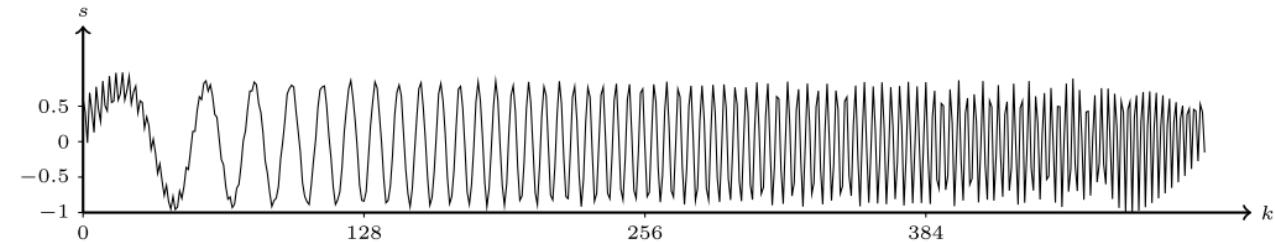
Reflectometry : measurement of transmission line characteristic impedance variation

Some new technologies developed

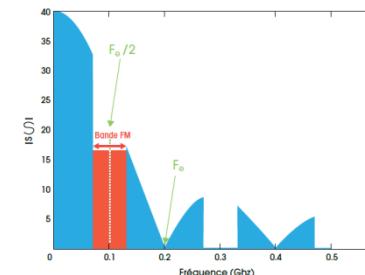
MCTDR (Multicarrier Time Domain Reflectometry)

- Probe signal corresponds to a sum of sine curves

$$s_n = \sum_{k=1}^{N/2} c_k \cos \left(\frac{2\pi k}{N} n + \theta_k \right)$$



- The probe signal spectrum is controllable by cancelling the desired carried signal

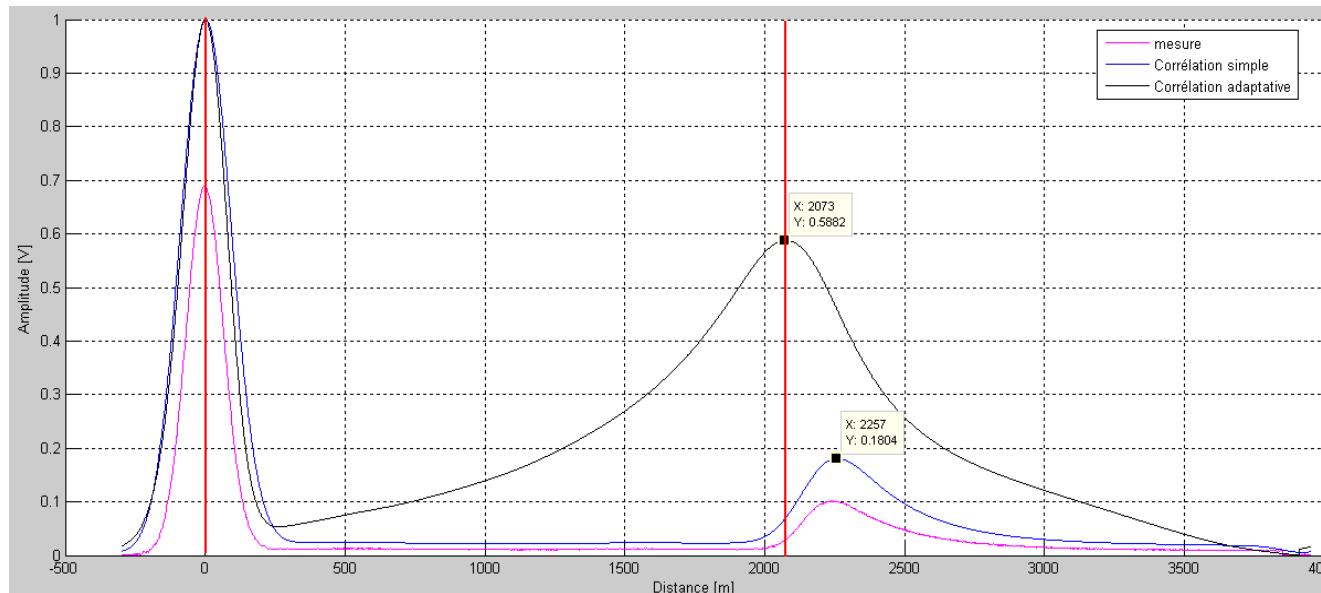


- Safe diagnosis : Harmless ness
- EMC Compliance
- Low sensitivity to SNR
- MCTDR in TRL > 5**

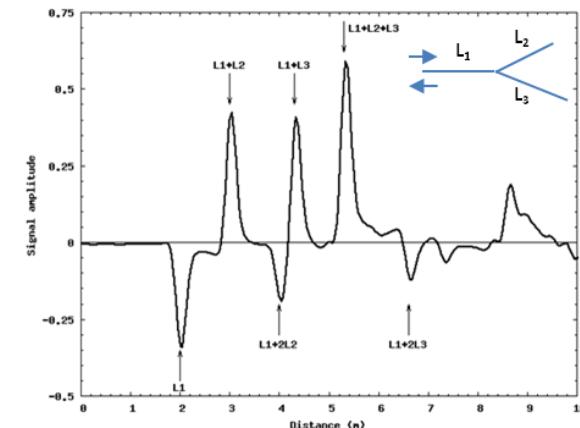
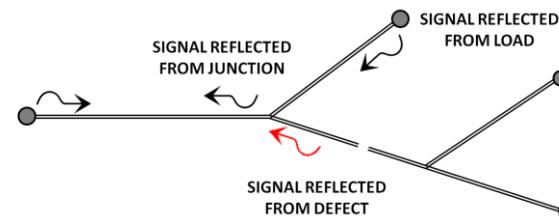
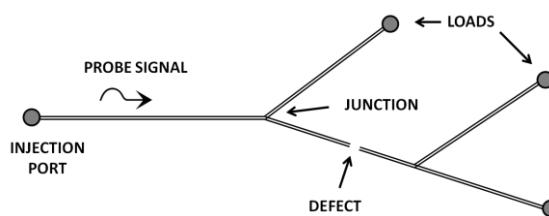
■ Adaptive correlation for performance enhancement :

- Sensitivity

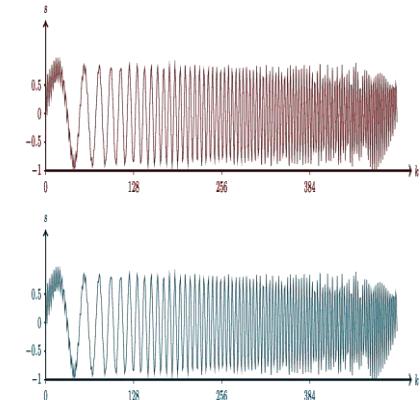
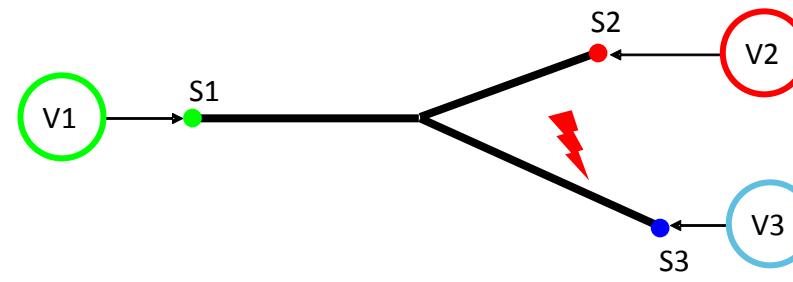
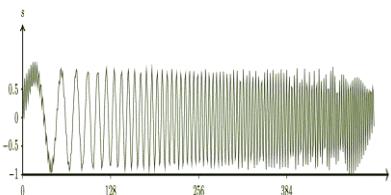
Railway signalization cable , reel length : 2km



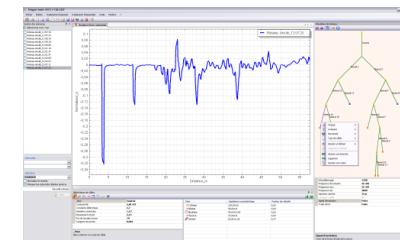
	Measure	Standard correlation	Adaptive correlation
Amplitude (V)	0.1	0.18	0.59
Localization (m)	2260	2257	2073
Relative error	13%	13 %	3.7 %



Distributed-MCTDR



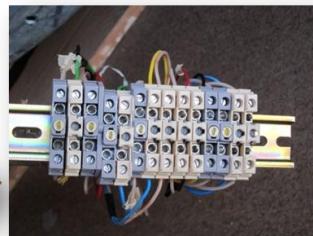
- The reflectometry distribution is obtained with a weighted mean process allowing a cross-correlation between reflectometers.
- Multi-sensing strategy allowing to avoid the ambiguity.
- A specific tool is proposed to facilitate the reflectometer deployment and to simulate the diagnosis strategy



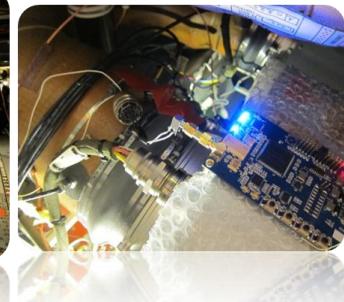
Technology integration



Railway



Avionic



DIAGNOCHIP, a 3 mm² 130nm integrated reflectometer

- A mixed Analog/Digital IP for real time processing
- 5cm resolution (4GHz guided wavelength)



Solar power



CEA breakthrough Valorisation

■ Implementation of CEA policy hard fault diagnosis:

- Licence sales
- Transfert project for academic laboratory
- Bilateral industrial project :
 - For specific research
 - For technological or know how transfert
- Spin off : Start up creation
⇒ Win MS



But also

- Collaborative research project with different partners



<http://www.win-ms.com>



Large cable networks



Cable infrastructure monitoring solution to fight against cable theft

- Targets:
 - Railways infrastructure
 - Tunnels
 - Roads
 - Public lighting

Aeronautic maintenance



Troubleshooting tool

- Targets:
 - Airlines
 - Pure-player MRO
 - Aircraft maker
 - Defense

Automotive maintenance



Troubleshooting tool

- Targets:
 - Auto makers
 - Maintenance and repair network
 - Trucks, buses,...

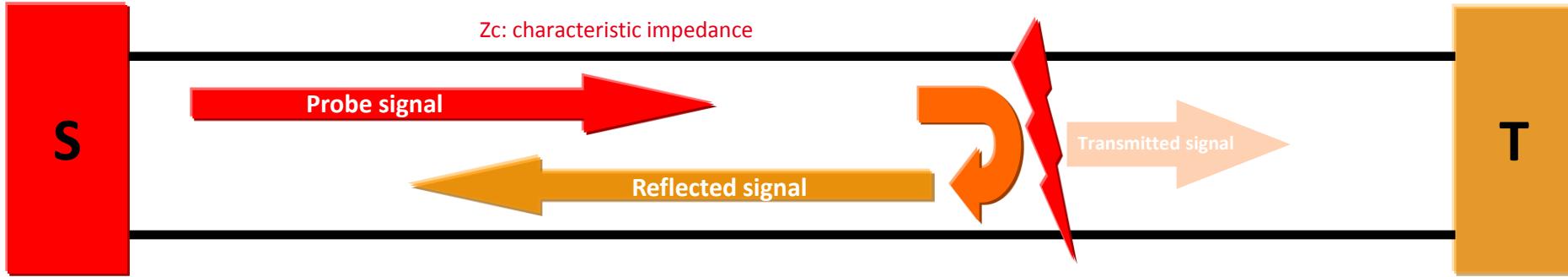
Contact: contact.dacle@cea.fr

leti & List

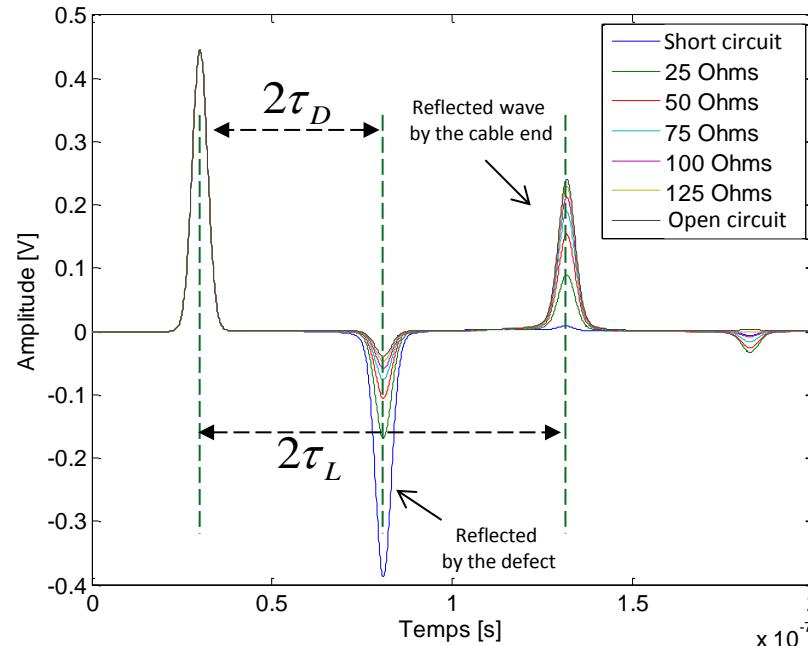
Some new technologies in progress

Reflectometry for soft defect

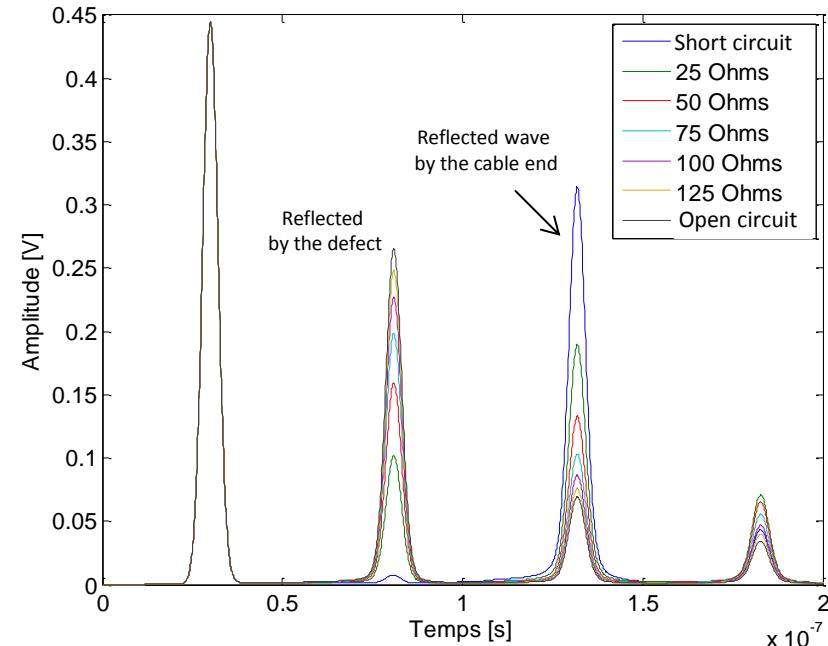
Injection Plan



Parallel defect



Serial defect



Reflectometry for soft defect

- External source of failure
 - Mechanical stress
 - Assembly errors
 - Corrosion, oxidation
 - Effect of environment s
- Internal source of failure
 - Manufacturing errors
 - Wear-out defect
 - Local hot-spot

Wear type	Primary signs	Detection method
Overheating of the wire	Wear zone	Visual inspection Reflectometry
Bad contact	Change in impedance Local hot spot	Thermal, Point by point test Reflectometry
Intermittent short circuit faults	Electromagnetic Magnetic Interference Electric arc	Visual inspection Reflectometry
Short circuit faults	Circuit-breaker system	Reflectometry
Broken insulation	Crack, damaged area	Visual inspection Reflectometry
Exposed conductor	Loss of the function Fire	Visual inspection Reflectometry
Corrosion	Loss of signal or data	Visual inspection Reflectrometry
Humidity	Loss of signal or data	Reflectometry

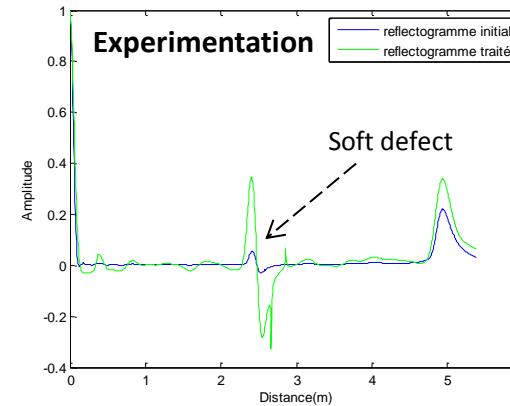
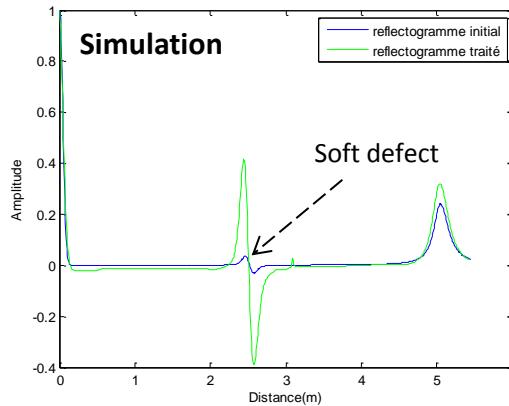
Wear out and/or Loss of the function

- Local alteration of R, L, C, G parameters
- Local alteration of the characteristic impedance Zc
- Local alteration of the propagation speed

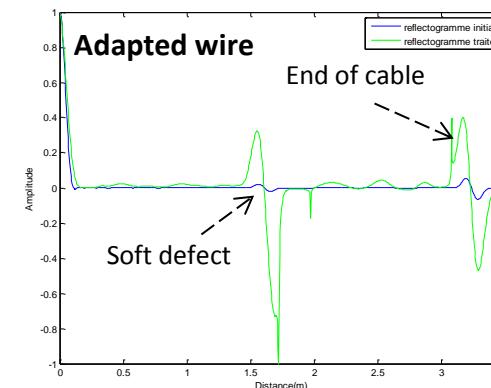
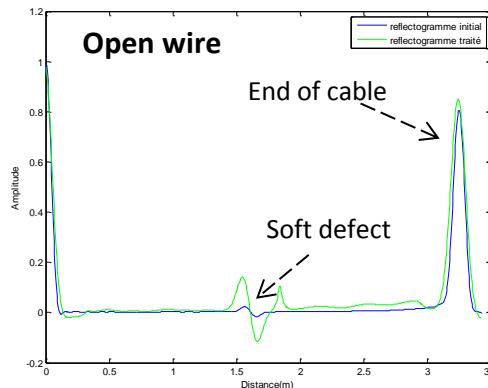
- 
- $\Gamma_L \neq 0$
- Open defect
 - Soft defect

Soft defect detection (chafing)

- One of our advance post processing for soft defect signature amplification



Cab_224b
Twisted pair (5 m) - Shielded - AWG24 0.25mm²
Soft defect = sheath + shield (pulled out) 2cm

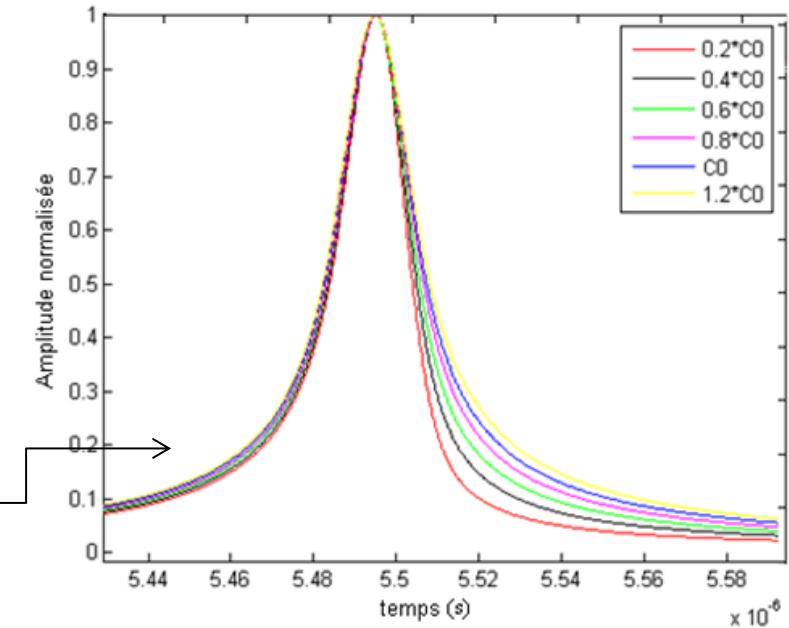
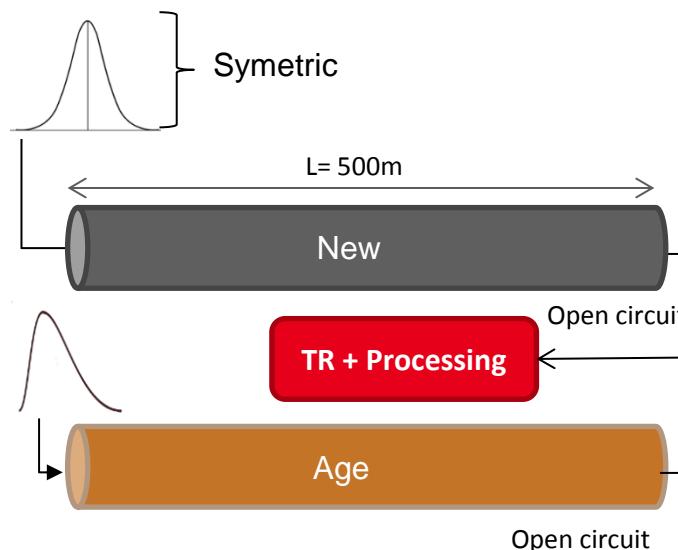


Coaxial cable RG58CU (3.20 mètres)
Soft defect = sheath + shield (pull out) 2cm



Prognostic diagnosis (aging)

- Aging monitoring based on time reversal reflectometry



Aging effect

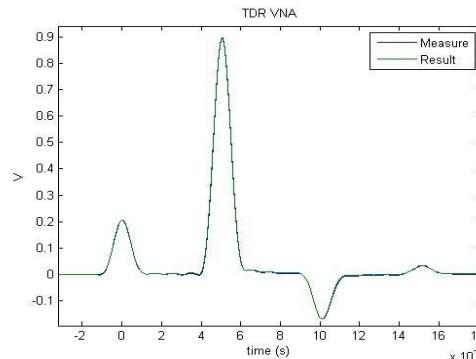
A horizontal timeline arrow points from left to right, indicating the progression of the aging simulations. The simulations are listed in the table below.

Simulations	$C_0 \times 1.2$	C_0	$C_0 \times 0.8$	$C_0 \times 0.6$	$C_0 \times 0.4$	$C_0 \times 0.2$
Asymmetry Coefficient	1.09	1	0.9045	0.7934	0.6683	0.5127

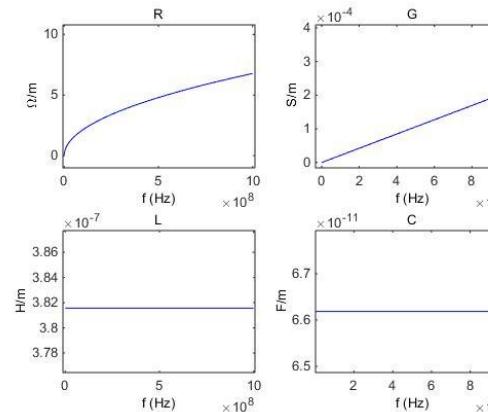
Cable and aging characterization

■ Cable characterization by RLCG parameters extraction

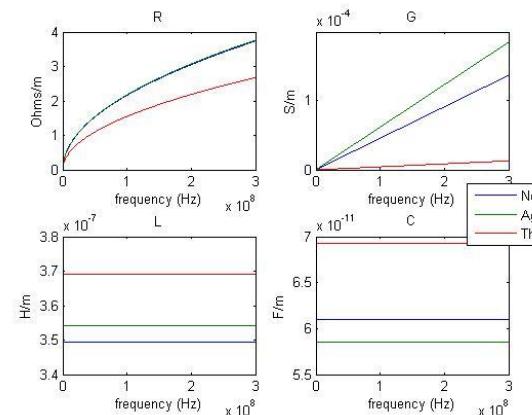
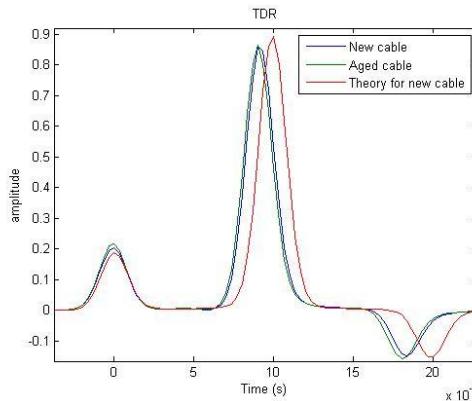
Coaxial (5 m) $Z_c = 75 \Omega$



$$\chi^2 = 3,7$$



■ Aging characterization



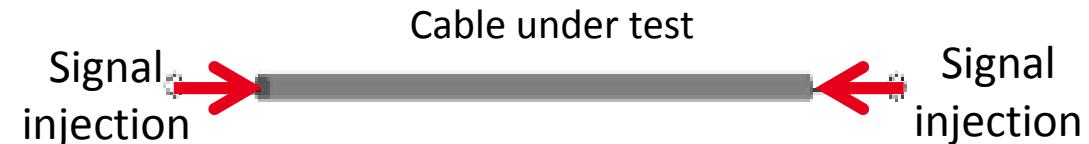
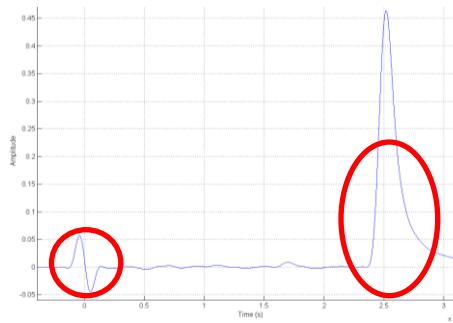
New



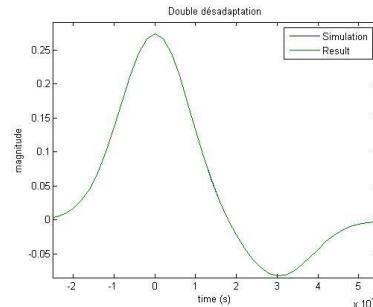
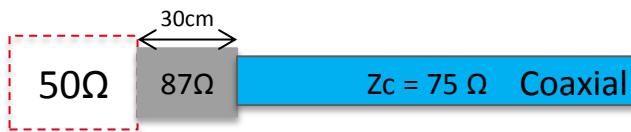
Aged

Coaxial (9,8 m) $Z_c = 75 \Omega$

Interconnection characterization

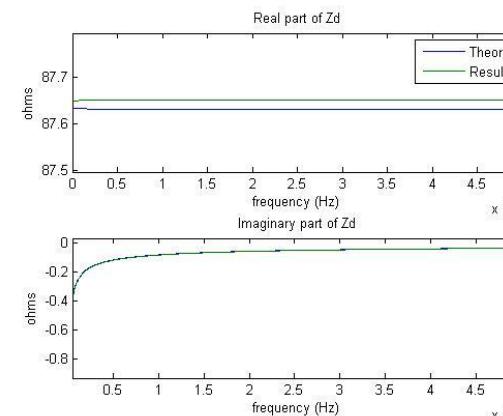


■ Cable connection and junction characterization



$V^2 = 4,65$

Likelihood ratio

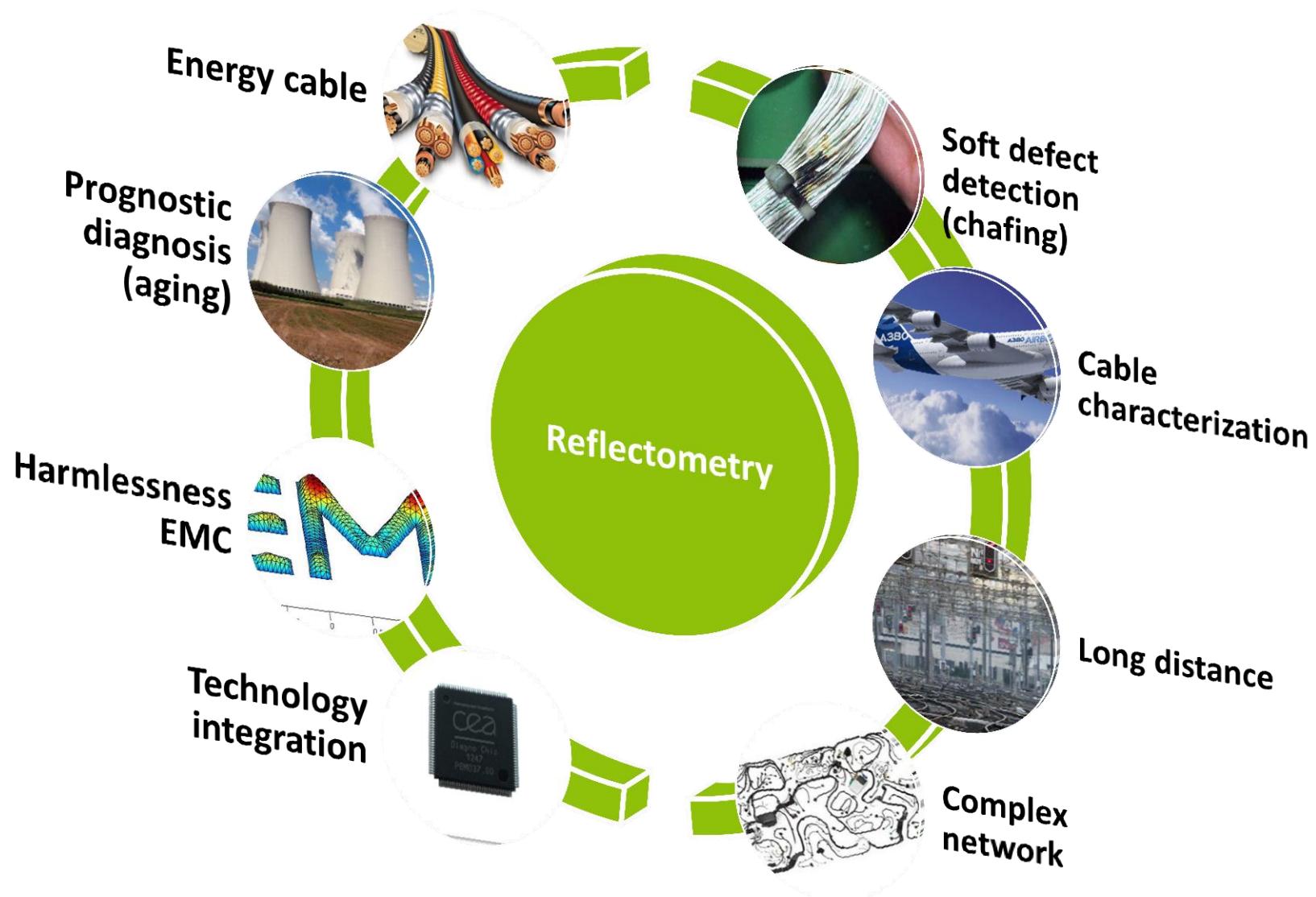


0,1% real part
1-2% imaginary part
 $l_d = 30 \text{ cm}$

⇒ To characterize interconnection or connector (database)

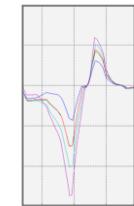
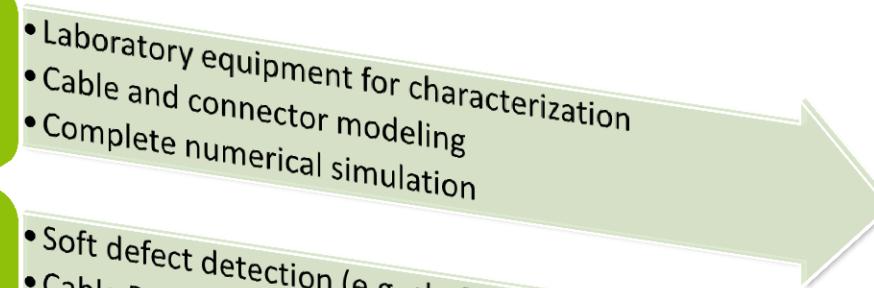
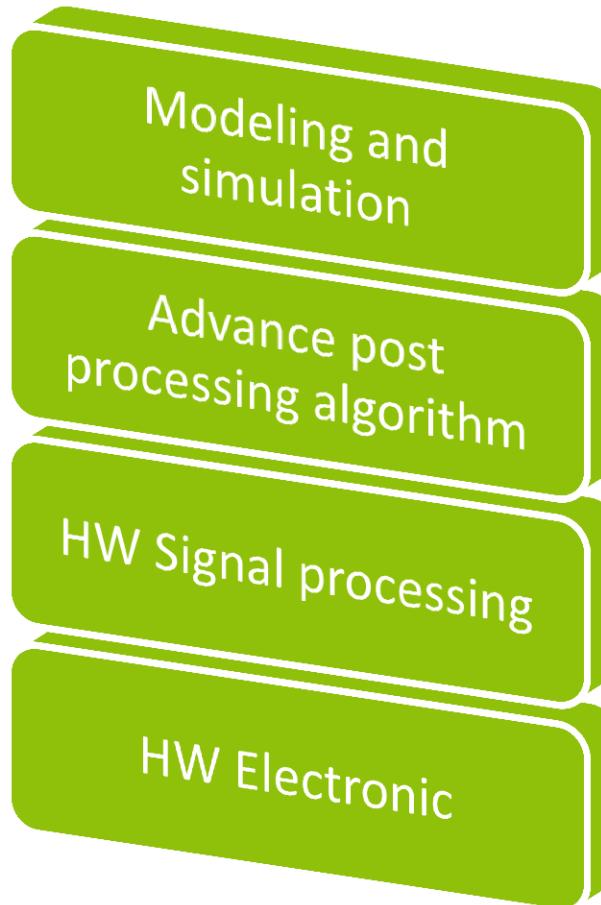
⇒ To diagnosis soft defect in the interconnection

Beyond reflectometry



Aera of expertise

More than 25 patents
And 60 publications



All these new technologies and know how in LFIC

What are the new technologies for the future ?

Which new application domain ?

- ⇒ Use a cable like environment sensor (temperature, humidity, ...)
- ⇒ New application domain : SHM for Composite

CEA ready to collaborate with industrials
to work in partnership



**Merci pour votre
attention**



leti

Centre de Grenoble
17 rue des Martyrs
38054 Grenoble Cedex

list

Centre de Saclay
Nano-Innov PC 172
91191 Gif sur Yvette Cedex